

<b>Notice of References Cited</b>	Application/Control No. 10/511,451	Applicant(s)/Patent Under Reexamination TAKENAKA ET AL.	
	Examiner Karen Masih	Art Unit 2837	Page 1 of 1

**U.S. PATENT DOCUMENTS**


*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0167641	08-2004	Kawai et al.	700/063
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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**FOREIGN PATENT DOCUMENTS**

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 Primary Examiner

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